

<b>Notice of References Cited</b>		Application/Control No. 10/647,775	Applicant(s)/Patent Under Reexamination YAN ET AL.	
		Examiner Khanh V. Nguyen	Art Unit 2817	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,316,992	11-2001	Miao et al.	330/9
*	B	US-6,498,929	12-2002	Tsurumi et al.	455/296
*	C	US-6,639,460	10-2003	Botker, Thomas L.	330/9
*	D	US-6,816,718	11-2004	Yan et al.	455/317
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.